Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/675,600	CHRISTOPH, MARKUS
	Examiner	Art Unit
	Tan V. Mai	2193

SEARCHED

Class	Subclass	Date	Examiner
708	320	12/20/2006	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	12/20/2006	MAI